

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 196727US0		SERIAL NO. 09/650,083	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Takehiro TSUTSUMI et al.			
				FILING DATE August 29, 2000		GROUP 1713	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
KCE	AA	5,631,309	05/20/97	YANAGI et al.			
	AB	5,702,510	12/30/97	YOSHIDA et al.			
	AC	5,736,606	04/07/98	YANAGI et al.			
	AD	5,852,074	12/22/98	TSUTSUMI et al.			
	AE	5,877,235	03/02/99	SAKUMA et al.			
	AF	6,031,019	02/29/00	TSUTSUMI et al.			
KCE	AG	5,998,501	12/07/99	TSUTSUMI et al.			
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>KCE</i>					Date Considered <i>3/80/02</i>		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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LIST OF REFERENCES CITED BY APPLICANT OTPE JC17A JUN 01 2001 OFFICE				APPLICANT Takehiro TSUTSUMI, et al.			
				FILING DATE August 29, 2000		GROUP 1713	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
llf	AA 4,229,219	10/21/80	Eric A. METZ				
llf	AB 5,151,128	09/29/92	Kyouko FUKUSHIMA, et al.				
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO			
llf	AJ 56-32566	04/02/81	JAPAN (with English Abstract and corr. US 4,229,219)			X	
	AK 4-211467	08/03/92	JAPAN (with corr. US 5,151,128)			X	
	AL 60-32866	02/20/85	JAPAN (with English Abstract)			X	
	AM 4-239067	08/26/92	JAPAN (with English Abstract)			X	
	AN 62-11781	01/20/87	JAPAN (with English Abstract)			X	
	AO 1-230685	09/14/89	JAPAN (with English Abstract)			X	
	AP 3-41171	02/21/91	JAPAN (with English Abstract)			X	
	AQ 6-157955	06/07/94	JAPAN (with English Abstract)			X	
	AR 62-127373	06/09/87	JAPAN (with English Abstract)			X	
	AS 5-5072	01/14/93	JAPAN (with English Abstract)			X	
	AT 62-121776	06/03/87	JAPAN (with English Abstract)			X	
	AU 5-140496	06/08/93	JAPAN (with English Abstract)			X	
llf	AV 62-243666	10/24/87	JAPAN (with English Abstract)			X	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner llf				Date Considered 3/30/02			

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